(b) Amendments to the Claims

Please cancel claims 9 and 56 without prejudice or disclaimer. Please amend claims 1-5, 8 and 11 as follows. A detailed listing of all the claims that are or were on the application is provided.

- --1. (Currently Amended) Process for decomposing powdery by-product and residual non-reacted gas comprising silicon or a compound thereof as a main component formed during processing a silicon-based amorphous or microcrystalline substrate or film comprising: An exhaust processing process of a processing apparatus for processing a substrate or a film, comprising the steps of:
- (a) during after processing a the substrate or a the film exhausting the unreacted gas and the powdery by-product, introducing a non-reacted gas and/or a by-product comprising silicon or a compound thereof as a main component into a trap means having therein a filament comprising a high-melting metal material comprising as a main component at least one of tungsten, molybdenum or and rhenium; and
- (b) decomposing the non-reacted gas and the powdery by-product by heating the filament to a temperature from 1400°C to 2200°C[[;]] and, whereby adherence of the powdery by-product to the trap means is reduced without compromising the integrity of the filament and vacuum seals around the trap processing the non-reacted gas and/or the by-product inside the trap means.

- 2. (Currently Amended) The exhaust processing process according to claim 1, wherein the processing apparatus is an apparatus for forming a deposited film is formed on the substrate by a plasma CVD process.
- 3. (Currently Amended) The exhaust processing process according to claim 1, wherein the processing apparatus is an apparatus for forming a deposited film is formed on the substrate by a thermal CVD process.
- 4. (Currently Amended) The exhaust processing process according to claim 1, wherein the processing apparatus is an apparatus for forming a deposited film is formed on the substrate by a photo CVD process.
- 5. (Currently Amended) The exhaust processing process according to claim 1, wherein the processing apparatus is an apparatus for processing the film is processed by a dry etching process.
 - 6. and 7. (Cancelled)
- 8. (Currently Amended) The exhaust processing process according to claim 1, wherein the configuration of the filament comprises a single linear shape, a plurality of linear shapes or a linear shape wound in spirals.

- 9. and 10. (Cancelled)
- 11. (Currently Amended) The exhaust processing process according to claim 1, wherein a wall surface of the trap is of a double structure, and an inner wall surface is detachable.
 - 12. 56. (Cancelled)